

*Predictions on charge collection efficiency  
in heavily irradiated Si detectors  
basing on the approach of active base*

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# *Outline*

- **Motivation**
- **Background: revising of double peak  $E(x)$  distribution with active base in Si detectors irradiated up to SuperLHC fluence**
- **Simulation of  $E(x)$  and collected charge in pad and strip detectors with a consideration of active base and comparison with experimental data**
- **Impact of the study**

**Conclusions**

# Motivation

Experiments that show **inconsistency** between predictions and established regularities for detectors irradiated at LHC fluence ( $< 10^{15} \text{ cm}^{-2}$ ), and results for the range of SuperLHC fluence ( $10^{15}$ -  $10^{16} \text{ cm}^{-2}$ )

- ◆ At high  $F$  the collected charge is larger than expected

*I. Mándić et al., RESMDD08, Florence, Italy, Oct 15-17, 2008;*

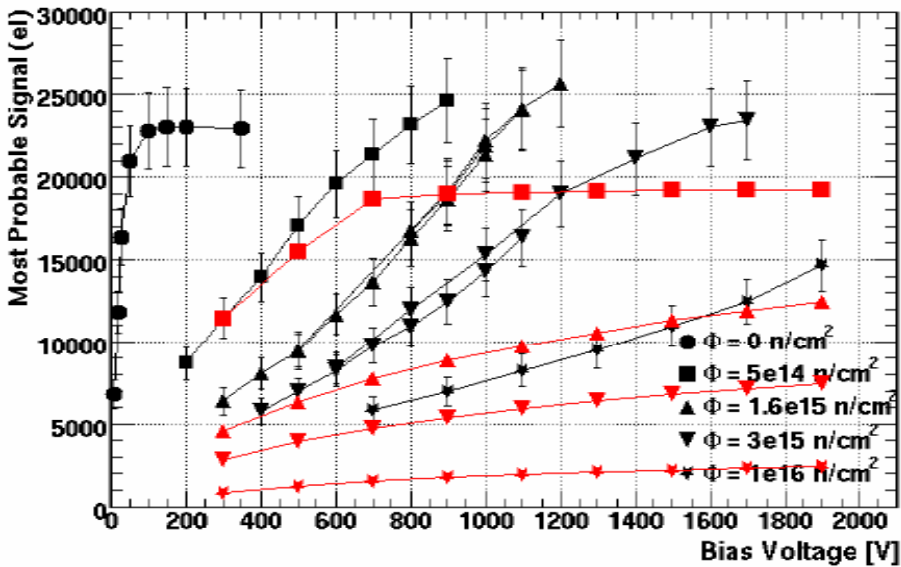
*G. Casse, 13 RD50 Workshop, CERN, Geneva, Nov 10-12, 2008*

- ◆ deviation of trapping probability ( $1/\tau$ ) vs.  $F$  from linear dependence at high  $F$

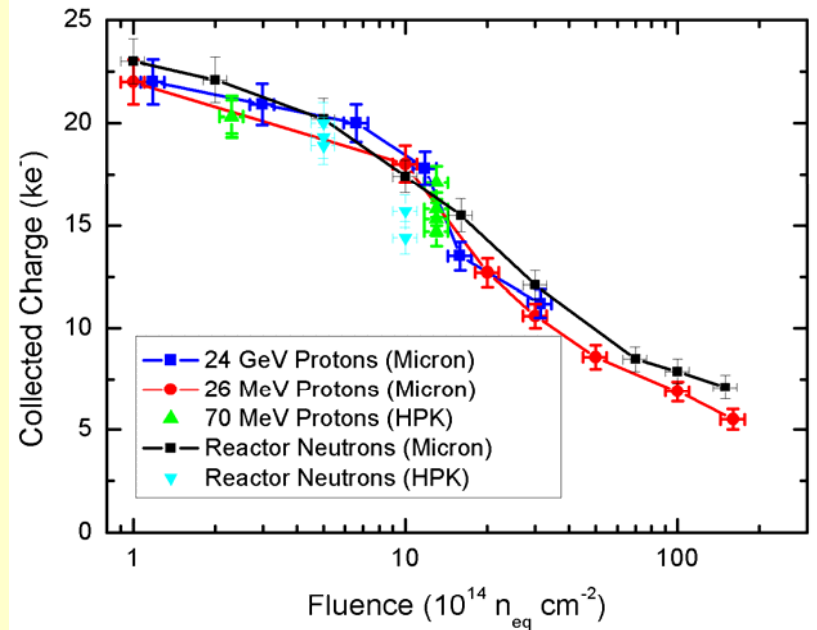
*E. Verbitskaya et al., 14 RD50 Workshop, Freiburg, June 3-5, 2009*

# Earlier results on the collected charge

I. Mándić et al., RESMDD08,  
Florence, Italy, Oct 15-17, 2008



G. Casse, 13 RD50 Workshop,  
CERN, Geneva, Nov 10-12, 2008

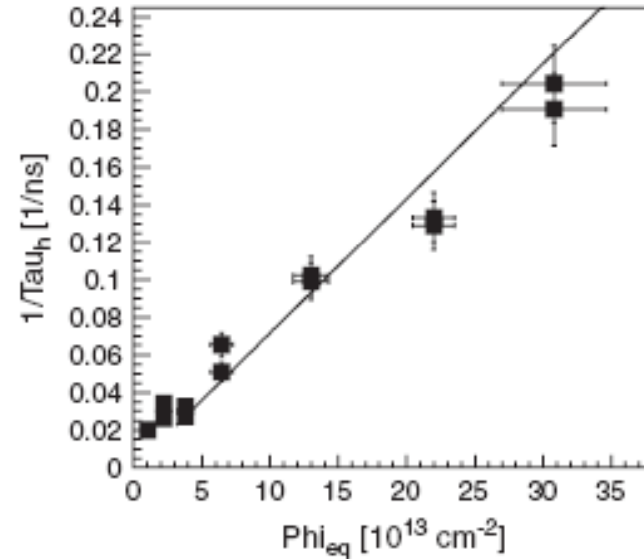
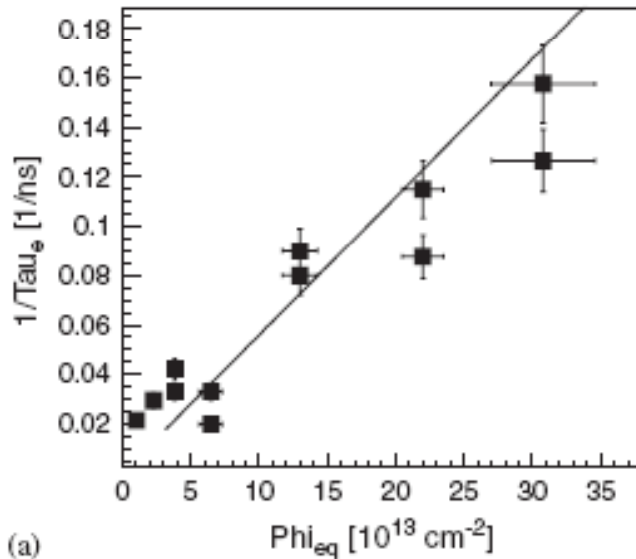


Black – experiment, red - simulations

**Collected charge is higher than simulated**

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# Earlier results on the trapping probability



A. Bates and M.Moll, *NIM A 555 (2005) 113–124*

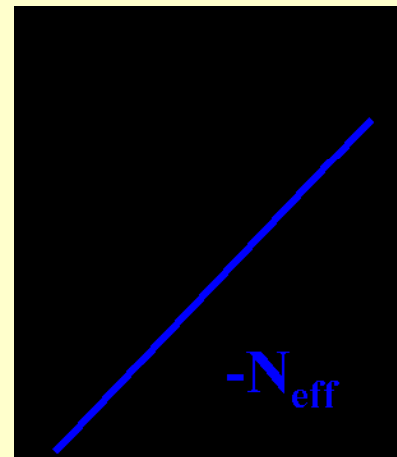
Deviation from linear dependence and a slight tendency to saturation at high  $F$  – underestimation?

E. Verbitskaya et al., 14 RD50 Workshop, Freiburg, June 3-5, 2009

# *Standard model of linear electric field distribution in irradiated Si detectors - Single Peak (SP) $E(x)$*

$N_{eff} = \text{const}$ ,  $E(x)$  – linear,  
 $V_{fd}$  derived from C-V curves

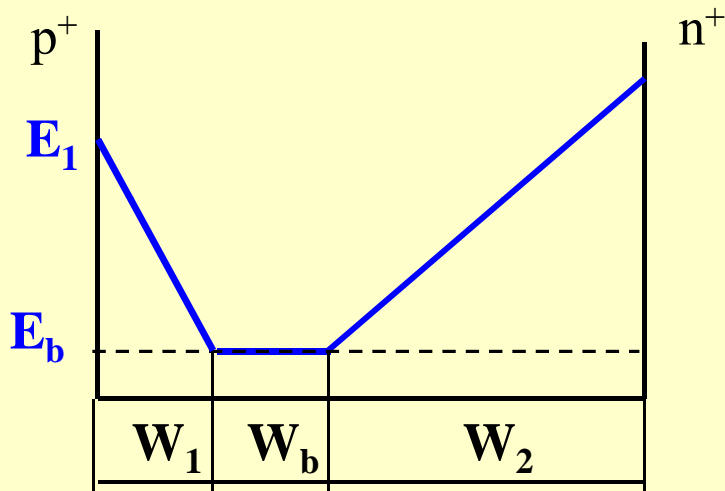
**Valid for  $F \sim 10^{13}$ - $10^{14}$  cm<sup>-2</sup>**



n-type Si  
beyond SCSI  
- $N_{eff}$

## Advanced model: Double Peak (DP) $E(x)$ distribution in heavily irradiated Si detectors

*E. Verbitskaya et al., NIM A 557 (2006) 528-539, and NIM A 583 (2007) 77-86*



▼ Three regions of heavily irradiated detector structure are considered

▼ **Reverse current flow creates potential difference and electric field  $E_b$  in the neutral base – base becomes active!  $w \rightarrow d$ ,  $CCE_g \rightarrow 1$**

▼ Free carriers generated by detected particles can drift in the entire detector bulk

**Active base is a key factor for charge collection**

## Tools for study

**Task:** revising of operation of the detectors with active base; receiving the quantitative data on the influence of  $E_b$  on  $Q_c$

### Simulation programs:

✓ Trapping program:  $E(x)$  profile with a consideration of carrier trapping to midgap energy levels: **DD**  $E_V + 0.48$  eV; **DA**  $E_C - 0.52$  eV; simulation is based on Shockley-Read-Hall statistics

✓ *CCE program: collected charge  $Q$  vs.  $V$  and  $F$  in pad detectors, and strip detectors with a consideration on weighting electric field; trapping is considered via  $\tau(F)$*

Simulations of  $Q_c(F)$  are made for 1 MeV neutron irradiation - SCS is evident,  $E(x)$ : ~ SCR at  $n^+$  contact ( $W_2$ ) + active base

$$\beta_e = 3.7 \cdot 10^{-16} \text{ ns}$$

$$\beta_h = 5.7 \cdot 10^{-16} \text{ ns}$$

*G. Kramberger,*

*NIM A 583 (2007) 49-57*

$$g_c = 0.02 \text{ cm}^{-1}$$

$$V = 900 \text{ V}$$

$$T = 263 \text{ K}$$

Comparison with experimental data of G. Casse;

$$V = 900 \text{ V}$$

*E. Verbitskaya et al., 14 RD50 Workshop, Freiburg, June 3-5, 2009*



## Considerations

$$Q \sim CCE_g \cdot CCE_{tr}$$

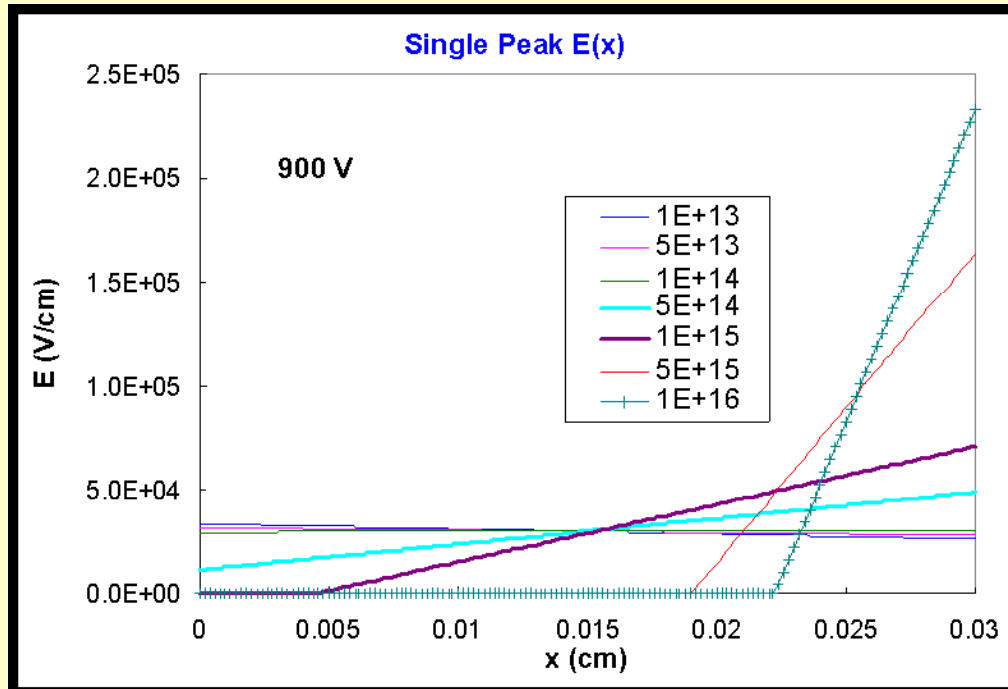
$CCE_g \sim w/d$  - geometrical component

$CCE_{tr}$  - trapping related component

- ✓ In case of active base  $w \rightarrow d$  and  $CCE_g \rightarrow 1$
- ✓ Maximum  $Q_c$  is expected at uniform E:  $w \equiv d$
- ✓ In case of uniform E and without trapping  
 $Q_c = Q_{\max} = 23 \text{ keV}$  at any F

# SP E(x)

Neutron irradiation, pads p-on-n, MCZ n-type Si,  $\rho \approx 2 \text{ k}$ ,  $d = 300 \text{ }\mu\text{m}$



At  $F > 10^{15} \text{ cm}^{-2}$  E at  $n^+$  contact becomes  $\geq 10^5 \text{ V/cm}$  – close to breakdown! **Questionable!**

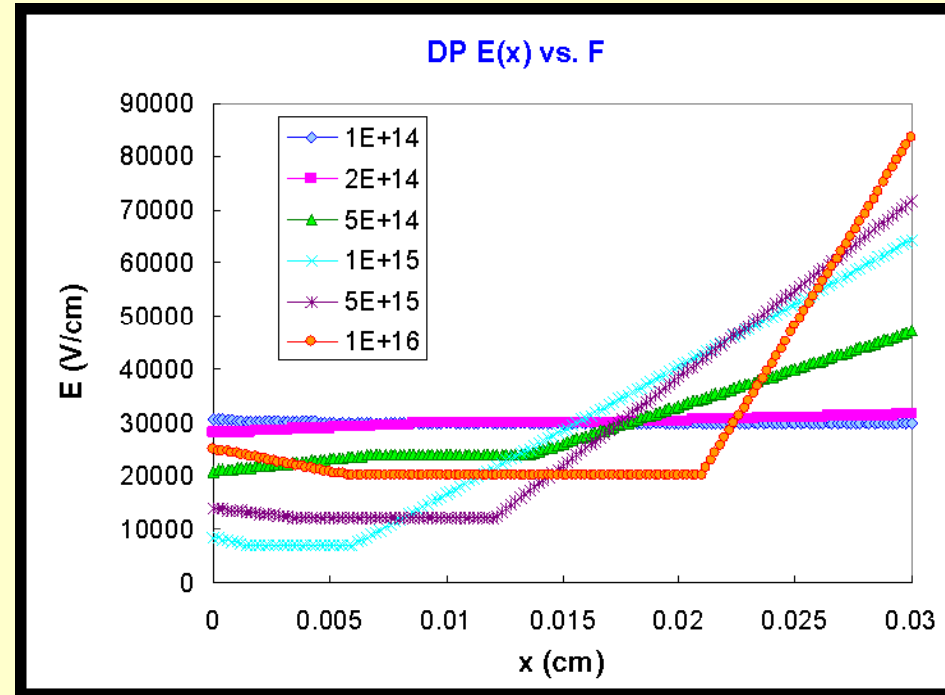
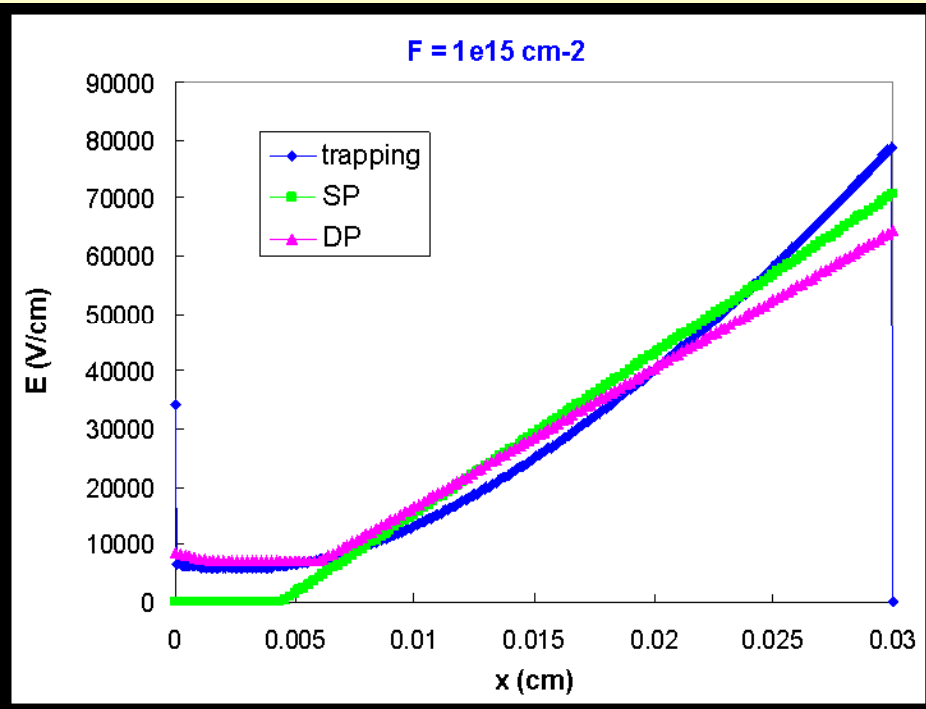
Data of I. Mándić are similar - simulated E may reach  $10^5 \text{ V/cm}$

BUT detectors well operate up to  $V \sim 2 \text{ kV}$ !

*E. Verbitskaya et al., 14 RD50 Workshop, Freiburg, June 3-5, 2009*

# DP E(x)

Pads, V = 900 V



**Trapping model:**

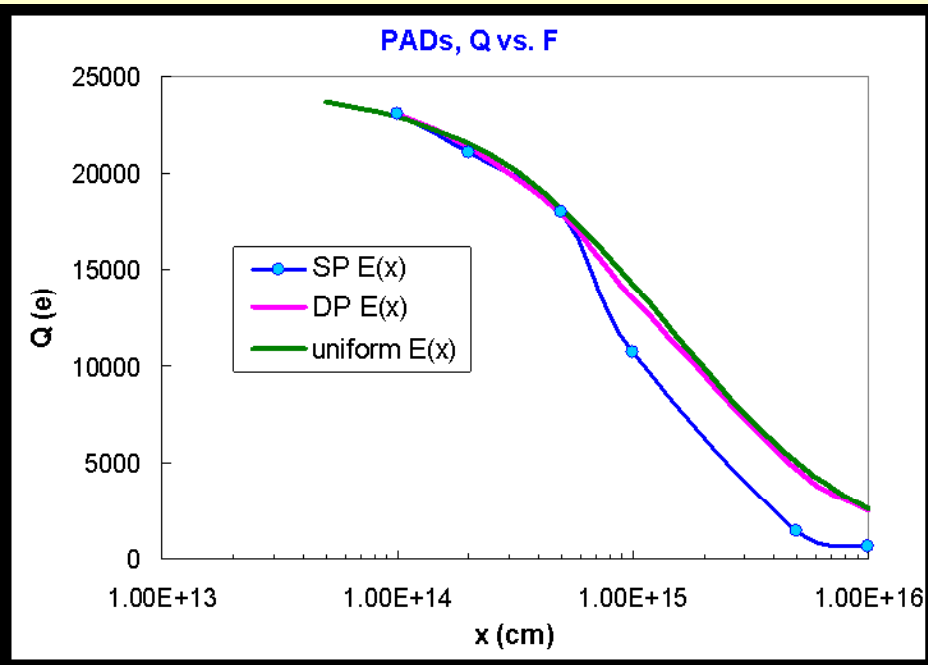
$$k = N_{DA}/N_{DD} = 1.35$$

E. Verbitskaya et al., *NIM A* 583 (2007) 77-86

- ✓ Electric field profile is asymmetric as it is for neutron irradiation
- ✓ E is below  $10^5$  V/cm

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# Collected charge for SP, DP and uniform $E(x)$ in pad $p^+ - n$ detectors



The collected charge is similar in detectors with DP and uniform  $E(x)$  – related to the saturation of drift velocity at  $E \sim \text{kV/cm}$

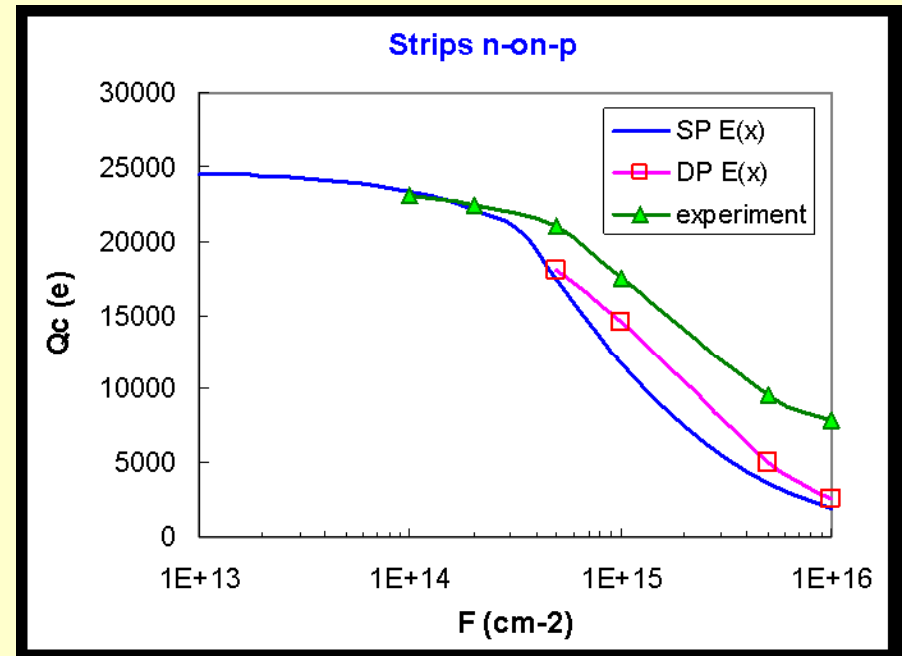
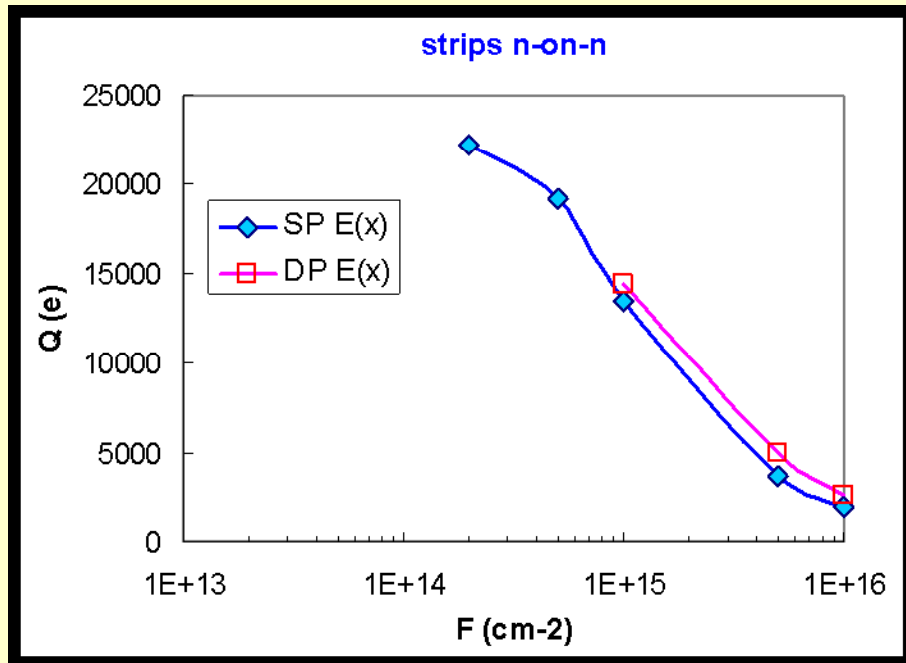
$$E_b: 1\text{-}20 \text{ kV/cm}$$

$$\text{at } F_{eq} 5 \cdot 10^{14}\text{-}1 \cdot 10^{16} \text{ cm}^{-2}$$

$$E_b = \rho \cdot I \rightarrow \sim F$$

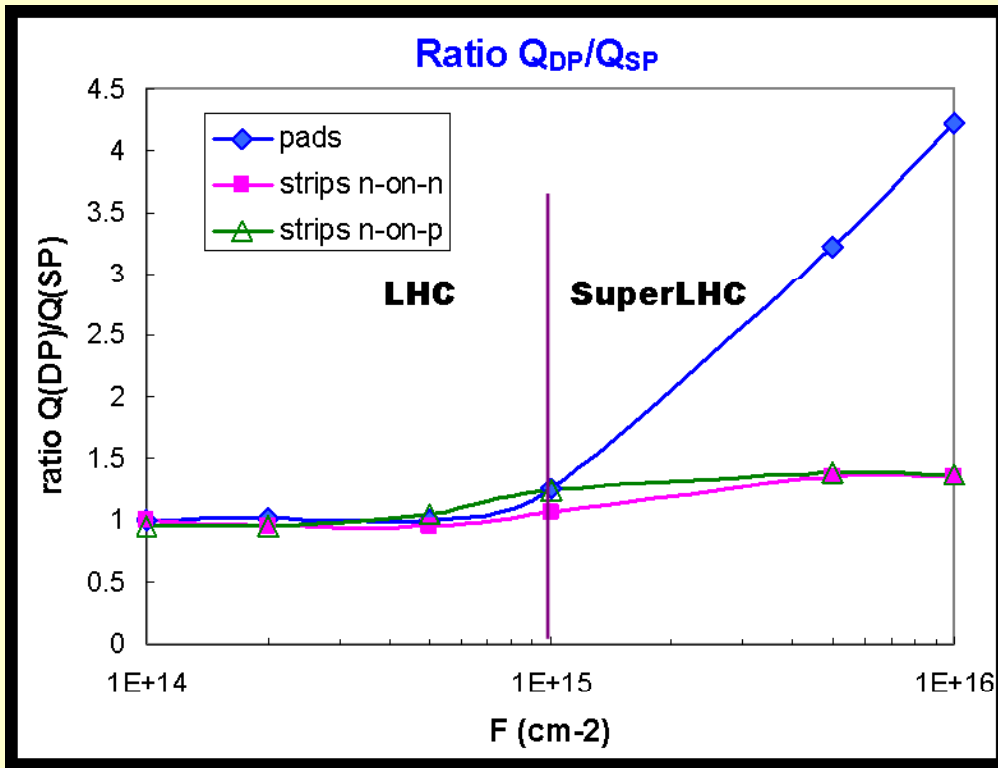
$\rho = \rho_i$  – in neutral bulk only,  
active base is modulated by current,  
 $\rho = 5 \cdot 10^4 \text{ Ohm}\cdot\text{cm}$

# $Q_c$ for SP and DP $E(x)$ in strip detectors



Experimental collected charge is still larger than  $Q_c$  simulated with DP  $E(x)$  profile

# Gain in the collected charge for DP $E(x)$ in pad and in strip detectors



Significant increase  
of collected charge is predicted  
in the SuperLHC fluence range

Pads: 4.2

Strips: 1.35

Strips: interference with  
weighting field which has  
its maximum near the strips

## *Possible reasons of enhanced experimental $Q_c$*

Additional factors that may lead to  $Q_c$  increase:

- ✓ underestimation of trapping time constants,
- ✓ avalanche effects,
- ✓ Poole-Frenkel effect.

At  $F = 1 \cdot 10^{16} \text{ cm}^{-2}$  adjustment of calculated  $Q_c$  to the experimental value of 7800e (with lower  $\beta$ ) gives calculated  $Q_c$  larger than experimental values at all  $F < 1 \cdot 10^{16} \text{ cm}^{-2}$ !

→ **the other factors are essential – now under study**

(Avalanche effects: V. Eremin, 14 RD40 workshop)

## *Impact of the study*

- ✓ Operation of irradiated Si detectors with active base is revised: Enhanced current of detectors irradiated by SuperLHC fluence leads to significant increase of the electric field in the base region.
- ✓ Innermost pixel detectors are p-on-n structure and  $E_b$  is the important parameter for prompt detector operation.
- ✓ Upcoming experiments in nuclear and high energy physics (FAIR project) require low mass detectors for which double sided strip design is optimal. P+ side of these detectors will operate in the low field defined by the active base properties.



## *Conclusions*

- ✓ Electric field in the active base is a key factor for charge collection increase in heavily irradiated Si detectors since the carrier transfer occurs in the entire detector.
- ✓ **The collected charge is insensitive to the value of this field that is related to saturation of drift velocity at  $E \sim \text{kV/cm}$  while  $E_b$  may reach 20 kV/cm.**
- ✓ **The active base leads to the increase of the collected charge in SuperLHC fluence range.**

# *Acknowledgments*

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*Thank you for attention!*

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